

# 74LVT244A; 74LVTH244A

3.3 V octal buffer/line driver; 3-state

Rev. 04 — 3 September 2008

Product data sheet

## 1. General description

The 74LVT244A; 74LVTH244A is a high-performance BiCMOS product designed for  $V_{CC}$  operation at 3.3 V.

This device is an octal buffer that is ideal for driving bus lines. The device features two output enables ( $\overline{1OE}$ ,  $\overline{2OE}$ ), each controlling four of the 3-state outputs.

## 2. Features

- Octal bus interface
- 3-state buffers
- Output capability: +64 mA and -32 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus hold data inputs eliminate need for external pull-up resistors to hold unused inputs
- Live insertion and extraction permitted
- Power-up 3-state
- No bus current loading when output is tied to 5 V bus
- Latch-up protection
  - ◆ JESD78 Class II exceeds 500 mA
- ESD protection:
  - ◆ HBM JESD22-A114E exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V

## 3. Ordering information

Table 1. Ordering information

| Type number                 | Package           |          |  |          |
|-----------------------------|-------------------|----------|--|----------|
|                             | Temperature range | Name     | Description  | Version  |
| 74LVT244AD<br>74LVTH244AD   | -40 °C to +85 °C  | SO20     | plastic small outline package; 20 leads;<br>body width 7.5 mm  | SOT163-1 |
| 74LVT244ADB<br>74LVTH244ADB | -40 °C to +85 °C  | SSOP20   | plastic shrink small outline package; 20 leads;<br>body width 5.3 mm   | SOT339-1 |
| 74LVT244APW<br>74LVTH244APW | -40 °C to +85 °C  | TSSOP20  | plastic thin shrink small outline package; 20 leads;<br>body width 4.4 mm  | SOT360-1 |
| 74LVT244ABQ<br>74LVTH244ABQ | -40 °C to +85 °C  | DHVQFN20 | plastic dual in-line compatible thermal enhanced<br>very thin quad flat package; no leads;<br>20 terminals; body 2.5 × 4.5 × 0.85 mm | SOT764-1 |

## 4. Functional diagram

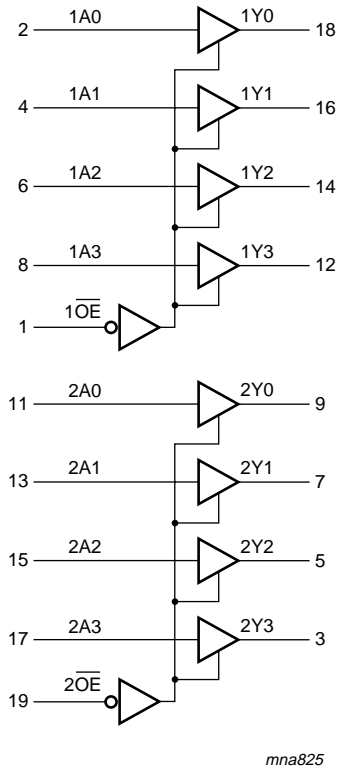


Fig 1. Logic symbol

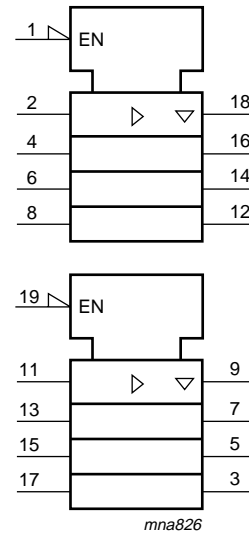
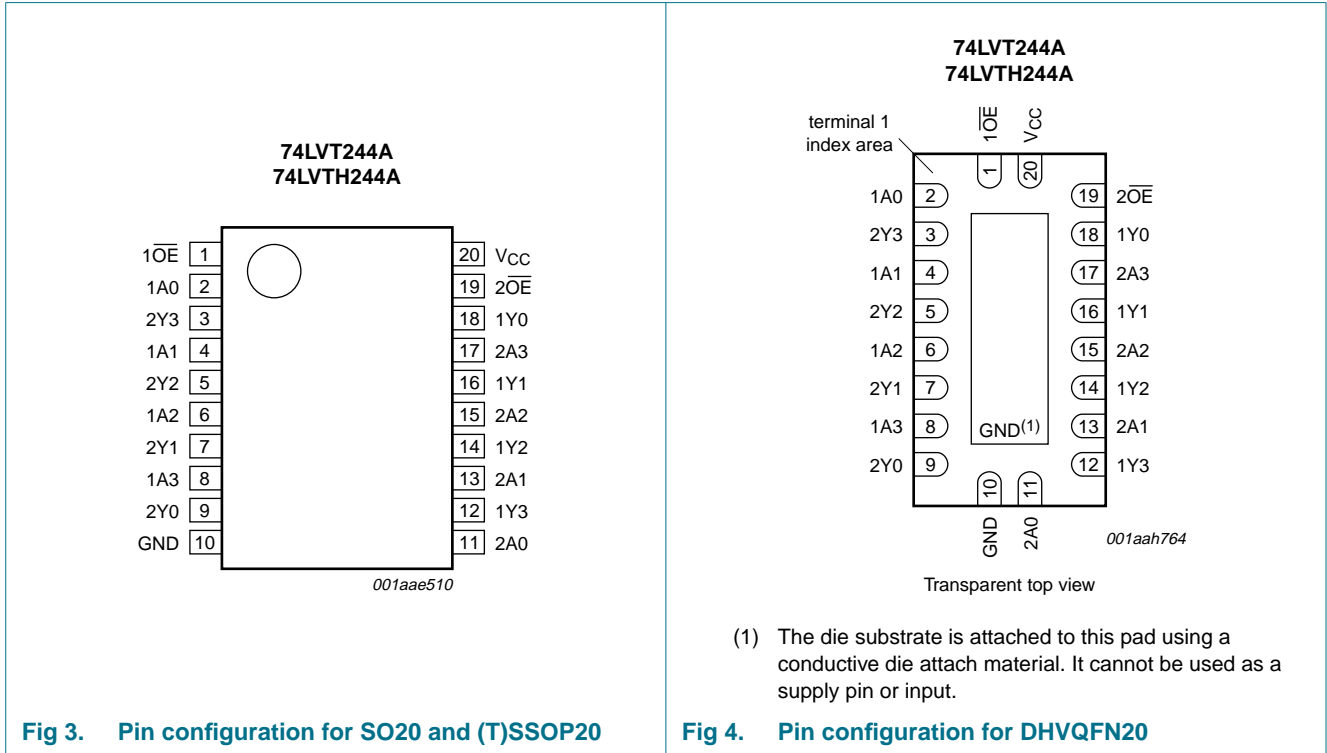


Fig 2. IEC logic symbol

## 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. Pin description

| Symbol                                | Pin            | Description                      |
|---------------------------------------|----------------|----------------------------------|
| 1 $\overline{OE}$ , 2 $\overline{OE}$ | 1, 19          | output enable input (active low) |
| 1A0, 1A1, 1A2, 1A3                    | 2, 4, 6, 8     | data input                       |
| 2Y0, 2Y1, 2Y2, 2Y3                    | 9, 7, 5, 3     | data output                      |
| GND                                   | 10             | ground (0 V)                     |
| 2A0, 2A1, 2A2, 2A3                    | 11, 13, 15, 17 | data input                       |
| 1Y0, 1Y1, 1Y2, 1Y3                    | 18, 16, 14, 12 | data output                      |
| V <sub>CC</sub>                       | 20             | supply voltage                   |

## 6. Functional description

### 6.1 Function table

Table 3. Function table [1]

| Control | Input | Output |
|---------|-------|--------|
| nOE     | nAn   | nYn    |
| L       | L     | L      |
|         | H     | H      |
| H       | X     | Z      |

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol           | Parameter               | Conditions                        | Min      | Max  | Unit |
|------------------|-------------------------|-----------------------------------|----------|------|------|
| V <sub>CC</sub>  | supply voltage          |                                   | -0.5     | +4.6 | V    |
| V <sub>I</sub>   | input voltage           |                                   | [1] -0.5 | +7.0 | V    |
| V <sub>O</sub>   | output voltage          | output in OFF-state or HIGH-state | [1] -0.5 | +7.0 | V    |
| I <sub>IK</sub>  | input clamping current  | V <sub>I</sub> < 0 V              | -        | -50  | mA   |
| I <sub>OK</sub>  | output clamping current | V <sub>O</sub> < 0 V              | -        | -50  | mA   |
| I <sub>O</sub>   | output current          | output in LOW-state               | -        | 128  | mA   |
|                  |                         | output in HIGH-state              | -        | -64  | mA   |
| T <sub>stg</sub> | storage temperature     |                                   | -65      | +150 | °C   |
| T <sub>j</sub>   | junction temperature    |                                   | [2] -    | 150  | °C   |
| P <sub>tot</sub> | total power dissipation | T <sub>amb</sub> = -40 to +85 °C  | [3]      | 500  | mW   |

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

[3] For SO20 packages: above 70 °C derate linearly with 8 mW/K.  
 For SSOP20 and TSSOP20 packages: above 60 °C derate linearly with 5.5 mW/K.  
 For DHVQFN20 packages: above 60 °C derate linearly with 4.5 mW/K.

## 8. Recommended operating conditions

Table 5. Operating conditions

| Symbol          | Parameter                 | Conditions | Min | Typ | Max | Unit |
|-----------------|---------------------------|------------|-----|-----|-----|------|
| V <sub>CC</sub> | supply voltage            |            | 2.7 | -   | 3.6 | V    |
| V <sub>I</sub>  | input voltage             |            | 0   | -   | 5.5 | V    |
| I <sub>OH</sub> | HIGH-level output current |            | -   | -   | -32 | mA   |

**Table 5. Operating conditions ...continued**

| Symbol           | Parameter                           | Conditions  | Min | Typ | Max | Unit |
|------------------|-------------------------------------|---|-----|-----|-----|------|
| I <sub>OL</sub>  | LOW-level output current            | none  | -   | -   | 32  | mA   |
|                  |                                     | current duty cycle ≤ 50 %; f <sub>i</sub> ≥ 1 kHz | -   | -   | 64  | mA   |
| T <sub>amb</sub> | ambient temperature                 | in free-air                                       | -40 | -   | +85 | °C   |
| Δt/ΔV            | input transition rise and fall rate | outputs enabled                                   | -   | -   | 10  | ns/V |

## 9. Static characteristics

**Table 6. Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| Symbol  | Parameter                          | Conditions  | Min                   | Typ                   | Max  | Unit |
|---|------------------------------------|---|-----------------------|-----------------------|------|------|
| <b>T<sub>amb</sub> = -40 °C to +85 °C [1]</b> |                                    |   |                       |                       |      |      |
| V <sub>IK</sub>                               | input clamping voltage             | V <sub>CC</sub> = 2.7 V; I <sub>IK</sub> = -18 mA   | -1.2                  | -0.9                  | -    | V    |
| V <sub>IH</sub>                               | HIGH-level input voltage           |   | 2.0                   | -                     | -    | V    |
| V <sub>IL</sub>                               | LOW-level input voltage            |   | -                     | -                     | 0.8  | V    |
| V <sub>OH</sub>                               | HIGH-level output voltage          | V <sub>CC</sub> = 2.7 V to 3.6 V; I <sub>OH</sub> = -100 μA   | V <sub>CC</sub> - 0.2 | V <sub>CC</sub> - 0.1 | -    | V    |
|   |                                    | V <sub>CC</sub> = 2.7 V to 3.6 V; I <sub>OH</sub> = -8 mA   | 2.4                   | 2.5                   | -    | V    |
|   |                                    | V <sub>CC</sub> = 3.0 V; I <sub>OH</sub> = -32 mA   | 2.0                   | 2.2                   | -    | V    |
| V <sub>OL</sub>                               | LOW-level output voltage           | V <sub>CC</sub> = 2.7 V; I <sub>OL</sub> = 100 μA   | -                     | 0.1                   | 0.2  | V    |
|   |                                    | V <sub>CC</sub> = 2.7 V; I <sub>OL</sub> = 24 mA  | -                     | 0.3                   | 0.5  | V    |
|   |                                    | V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 16 mA  | -                     | 0.25                  | 0.4  | V    |
|   |                                    | V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 32 mA  | -                     | 0.3                   | 0.5  | V    |
|   |                                    | V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 64 mA  | -                     | 0.4                   | 0.55 | V    |
| I <sub>I</sub>                                | input leakage current              | all input pins  |                       |                       |      |      |
|   |                                    | V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V  | -                     | 0.1                   | 10   | μA   |
|   |                                    | control pins  |                       |                       |      |      |
|   |                                    | V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub> or GND  | -                     | ±0.1                  | ±1   | μA   |
|   |                                    | data pins [2]   |                       |                       |      |      |
|   |                                    | V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>CC</sub>   | -                     | 0.1                   | 1    | μA   |
|   |                                    | V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = 0 V   | -5                    | -1                    | -    | μA   |
| I <sub>OFF</sub>                              | power-off leakage current          | V <sub>CC</sub> = 0 V; V <sub>I</sub> or V <sub>O</sub> = 0 V to 4.5 V  | -                     | 1                     | ±100 | μA   |
| I <sub>BHL</sub>                              | bus hold LOW current               | V <sub>CC</sub> = 3 V; V <sub>I</sub> = 0.8 V [3]   | 75                    | 150                   | -    | μA   |
| I <sub>BHH</sub>                              | bus hold HIGH current              | V <sub>CC</sub> = 3 V; V <sub>I</sub> = 2.0 V   | -                     | -150                  | -75  | μA   |
| I <sub>BHLO</sub>                             | bus hold LOW overdrive current     | nAn input; V <sub>CC</sub> = 0 V to 3.6 V; V <sub>I</sub> = 3.6 V   | 500                   | -                     | -    | μA   |
| I <sub>BHHO</sub>                             | bus hold HIGH overdrive current    | nAn input; V <sub>CC</sub> = 0 V to 3.6 V; V <sub>I</sub> = 3.6 V   | -                     | -                     | -500 | μA   |
| I <sub>LO</sub>                               | output leakage current             | nYn output in HIGH-state when V <sub>O</sub> > V <sub>CC</sub> ; V <sub>O</sub> = 5.5 V; V <sub>CC</sub> = 3.0 V                    | -                     | 60                    | 125  | μA   |
| I <sub>O(pu/pd)</sub>                         | power-up/power-down output current | V <sub>CC</sub> ≤ 1.2 V; V <sub>O</sub> = 0.5 V to V <sub>CC</sub> ; V <sub>I</sub> = GND or V <sub>CC</sub> ; nOE = don't care [4] | -                     | ±1                    | ±100 | μA   |

**Table 6. Static characteristics ...continued**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| Symbol           | Parameter                 | Conditions   | Min | Typ  | Max  | Unit |    |
|------------------|---------------------------|--|-----|------|------|------|----|
| I <sub>OZ</sub>  | OFF-state output current  | V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>   |     |      |      |      |    |
|                  |                           | V <sub>O</sub> = 3.0 V   | -   | 1    | 5    | μA   |    |
|                  |                           | V <sub>O</sub> = 0.5 V   | -5  | -1   | -    | μA   |    |
| I <sub>CC</sub>  | supply current            | V <sub>CC</sub> = 3.6 V; V <sub>I</sub> = GND or V <sub>CC</sub> ;<br>I <sub>O</sub> = 0 A   |     |      |      |      |    |
|                  |                           | output HIGH  | -   | 0.13 | 0.19 | mA   |    |
|                  |                           | output LOW   | -   | 3    | 12   | mA   |    |
|                  |                           | outputs disabled   | [5] | -    | 0.13 | 0.19 | mA |
| ΔI <sub>CC</sub> | additional supply current | per input pin; V <sub>CC</sub> = 3.0 V to 3.6 V;<br>one input at V <sub>CC</sub> - 0.6 V and other<br>inputs at V <sub>CC</sub> or GND | [6] | -    | 0.1  | 0.2  | mA |
| C <sub>I</sub>   | input capacitance         | V <sub>I</sub> = 0 V or 3.0 V  | -   | 4    | -    | pF   |    |
| C <sub>O</sub>   | output capacitance        | outputs disabled; V <sub>O</sub> = 0 V or 3.0 V  | -   | 8    | -    | pF   |    |

[1] All typical values are at T<sub>amb</sub> = 25 °C.

[2] Unused pins at V<sub>CC</sub> or GND.

[3] This is the bus hold overdrive current required to force the input to the opposite logic state.

[4] This parameter is valid for any V<sub>CC</sub> between 0 V and 1.2 V with a transition time of up to 10 ms. From V<sub>CC</sub> = 1.2 V to V<sub>CC</sub> = 3.3 V ± 0.3 V a transition time of 100 μs is permitted. This parameter is valid for T<sub>amb</sub> = 25 °C only.

[5] I<sub>CC</sub> is measured with outputs pulled to V<sub>CC</sub> or GND.

[6] This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND.

## 10. Dynamic characteristics

**Table 7. Dynamic characteristics**

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 7](#).

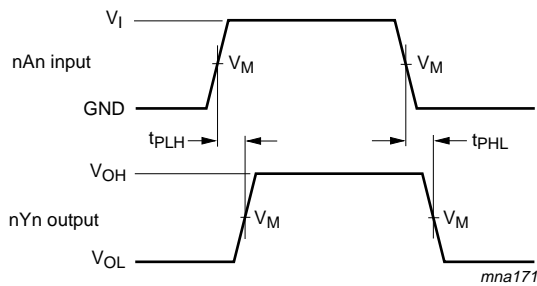
| Symbol  | Parameter                           | Conditions                               | Min | Typ | Max | Unit |
|---|-------------------------------------|--|-----|-----|-----|------|
| <b>T<sub>amb</sub> = -40 °C to +85 °C [1]</b> |                                     |  |     |     |     |      |
| t <sub>PLH</sub>                              | LOW to HIGH propagation delay       | nAn to nYn; see <a href="#">Figure 5</a> |     |     |     |      |
|   |                                     | V <sub>CC</sub> = 2.7 V                  | -   | -   | 5.0 | ns   |
|   |                                     | V <sub>CC</sub> = 3.0 V to 3.6 V         | 1   | 2.5 | 4.1 | ns   |
| t <sub>PHL</sub>                              | HIGH to LOW propagation delay       | nAn to nYn; see <a href="#">Figure 5</a> |     |     |     |      |
|   |                                     | V <sub>CC</sub> = 2.7 V                  | -   | -   | 5.1 | ns   |
|   |                                     | V <sub>CC</sub> = 3.0 V to 3.6 V         | 1   | 2.6 | 4.1 | ns   |
| t <sub>PZH</sub>                              | OFF-state to HIGH propagation delay | see <a href="#">Figure 6</a>             |     |     |     |      |
|   |                                     | V <sub>CC</sub> = 2.7 V                  | -   | -   | 6.3 | ns   |
|   |                                     | V <sub>CC</sub> = 3.0 V to 3.6 V         | 1   | 3.2 | 5.2 | ns   |
| t <sub>PZL</sub>                              | OFF-state to LOW propagation delay  | see <a href="#">Figure 6</a>             |     |     |     |      |
|   |                                     | V <sub>CC</sub> = 2.7 V                  | -   | -   | 6.7 | ns   |
|   |                                     | V <sub>CC</sub> = 3.0 V to 3.6 V         | 1.1 | 3.1 | 5.2 | ns   |
| t <sub>PHZ</sub>                              | HIGH to OFF-state propagation delay | see <a href="#">Figure 6</a>             |     |     |     |      |
|   |                                     | V <sub>CC</sub> = 2.7 V                  | -   | -   | 6.3 | ns   |
|   |                                     | V <sub>CC</sub> = 3.0 V to 3.6 V         | 1.9 | 3.3 | 5.6 | ns   |

**Table 7. Dynamic characteristics ...continued**  
 Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 7](#).

| Symbol    | Parameter                          | Conditions                              | Min | Typ | Max | Unit |
|-----------|------------------------------------|---|-----|-----|-----|------|
| $t_{PLZ}$ | LOW to OFF-state propagation delay | see <a href="#">Figure 6</a>            |     |     |     |      |
|           |                                    | $V_{CC} = 2.7\text{ V}$                 | -   | -   | 5.6 | ns   |
|           |                                    | $V_{CC} = 3.0\text{ V to }3.6\text{ V}$ | 1.8 | 3.3 | 5.1 | ns   |

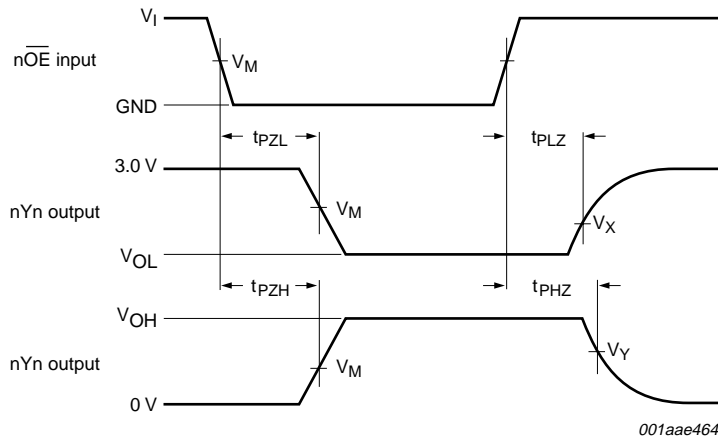
[1] All typical values are at  $V_{CC} = 3.3\text{ V}$  and  $T_{amb} = 25\text{ }^\circ\text{C}$ .

## 11. Waveforms



Measurement points are given in [Table 8](#).  
 $V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

**Fig. 5. Propagation delay input (nAn) to output (nYn) propagation delays**

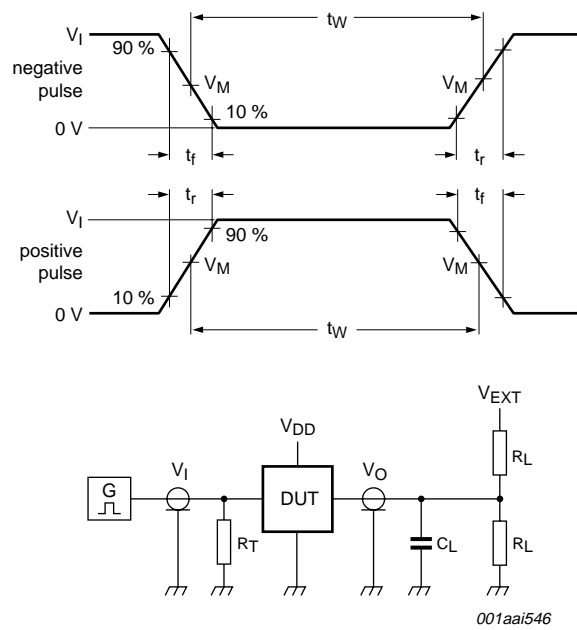


Measurement points are given in [Table 8](#).  
 $V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

**Fig. 6. 3-state output enable and disable times**

**Table 8. Measurement points**

| Input | Output |                         |                         |
|-------|--------|-------------------------|-------------------------|
| $V_M$ | $V_M$  | $V_X$                   | $V_Y$                   |
| 1.5 V | 1.5 V  | $V_{OL} + 0.3\text{ V}$ | $V_{OH} - 0.3\text{ V}$ |



Test data is given in [Table 9](#).

Definitions test circuit:

$R_L$  = Load resistance.

$C_L$  = Load capacitance including jig and probe capacitance.

$R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

$V_{EXT}$  = Test voltage for switching times.

**Fig 7. Load circuitry for switching times**

**Table 9. Test data**

| Input |               |        |               | Load  |              | $V_{EXT}$          |                    |                    |
|-------|---------------|--------|---------------|-------|--------------|--------------------|--------------------|--------------------|
| $V_I$ | $f_i$         | $t_W$  | $t_r, t_f$    | $C_L$ | $R_L$        | $t_{PHZ}, t_{PZH}$ | $t_{PLZ}, t_{PZL}$ | $t_{PLH}, t_{PHL}$ |
| 2.7 V | $\leq 10$ MHz | 500 ns | $\leq 2.5$ ns | 50 pF | 500 $\Omega$ | GND                | 6 V                | open               |



12. Package outline

SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1

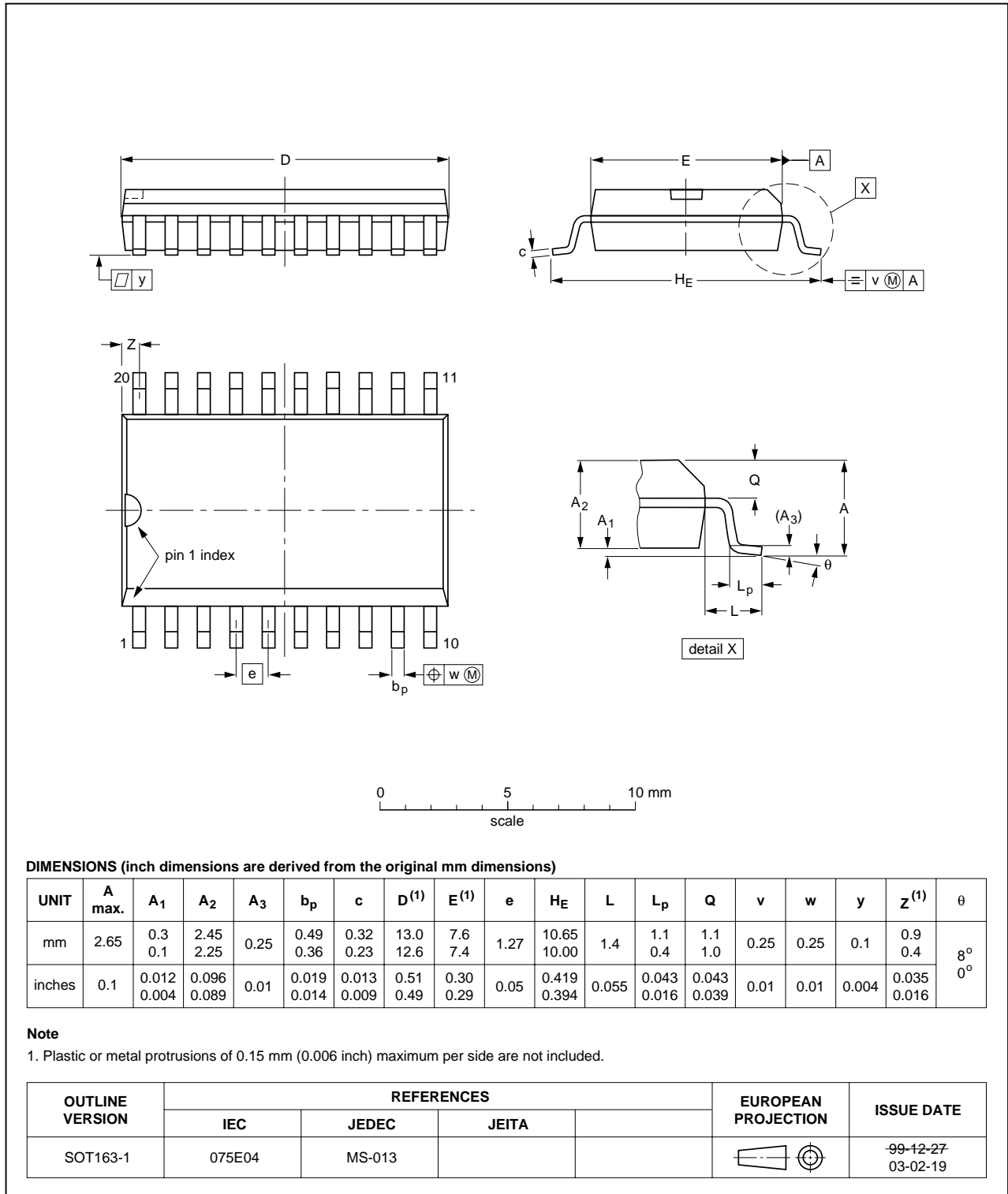


Fig 8. Package outline SOT163-1 (SO20)

SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1

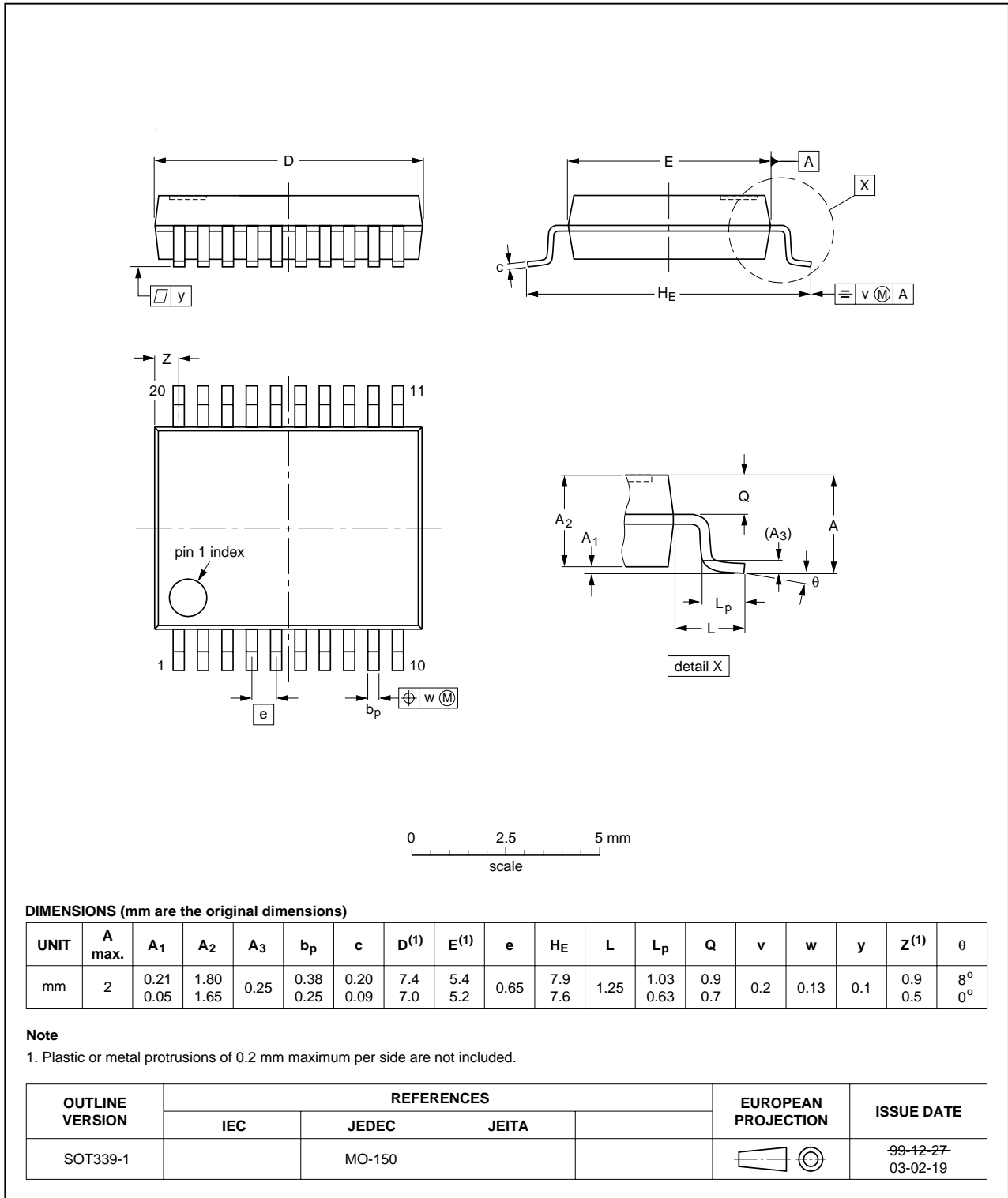


Fig 9. Package outline SOT339-1 (SSOP20)

TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1

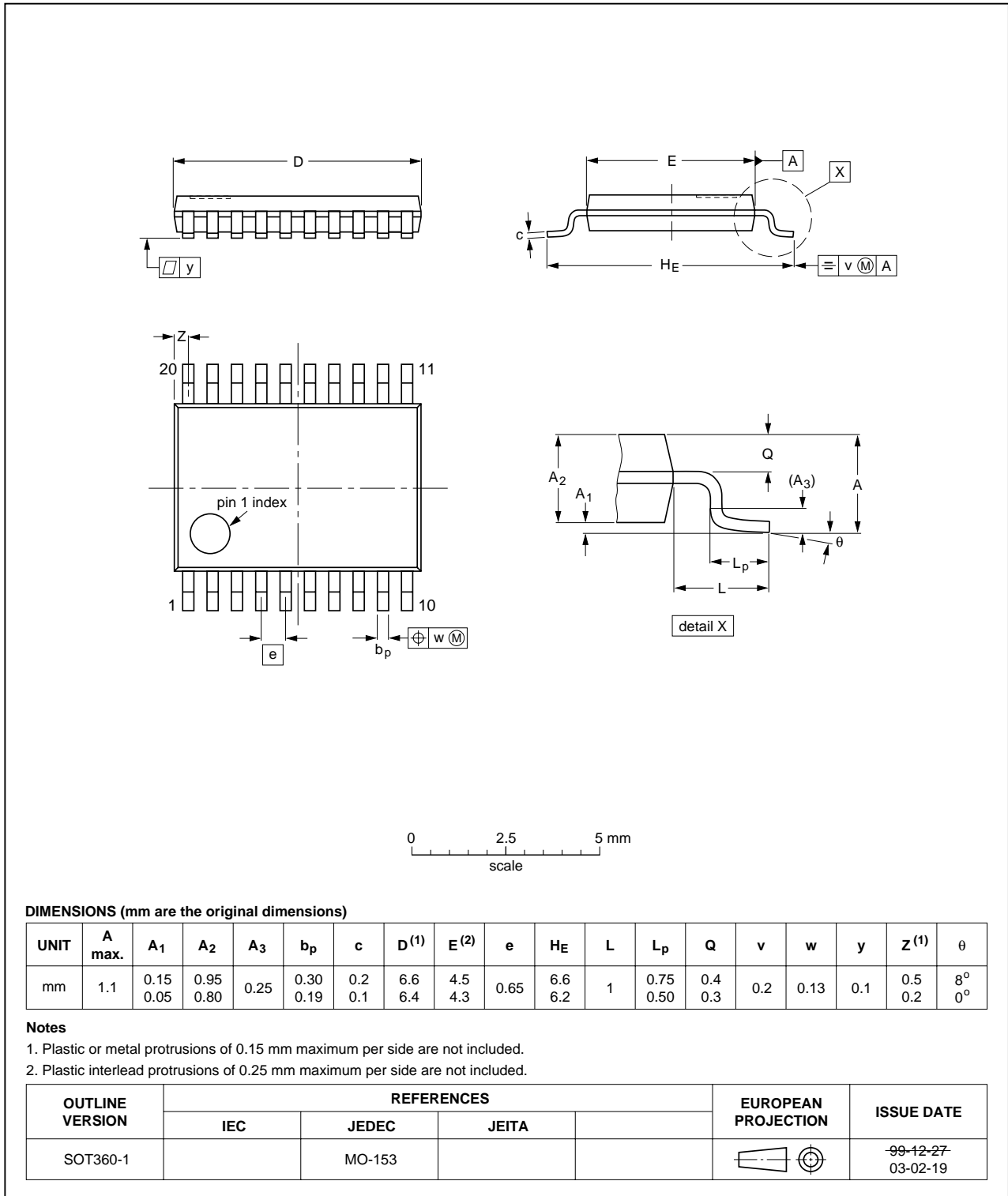


Fig 10. Package outline SOT360-1 (TSSOP20)

DHVQFN20: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 x 4.5 x 0.85 mm

SOT764-1

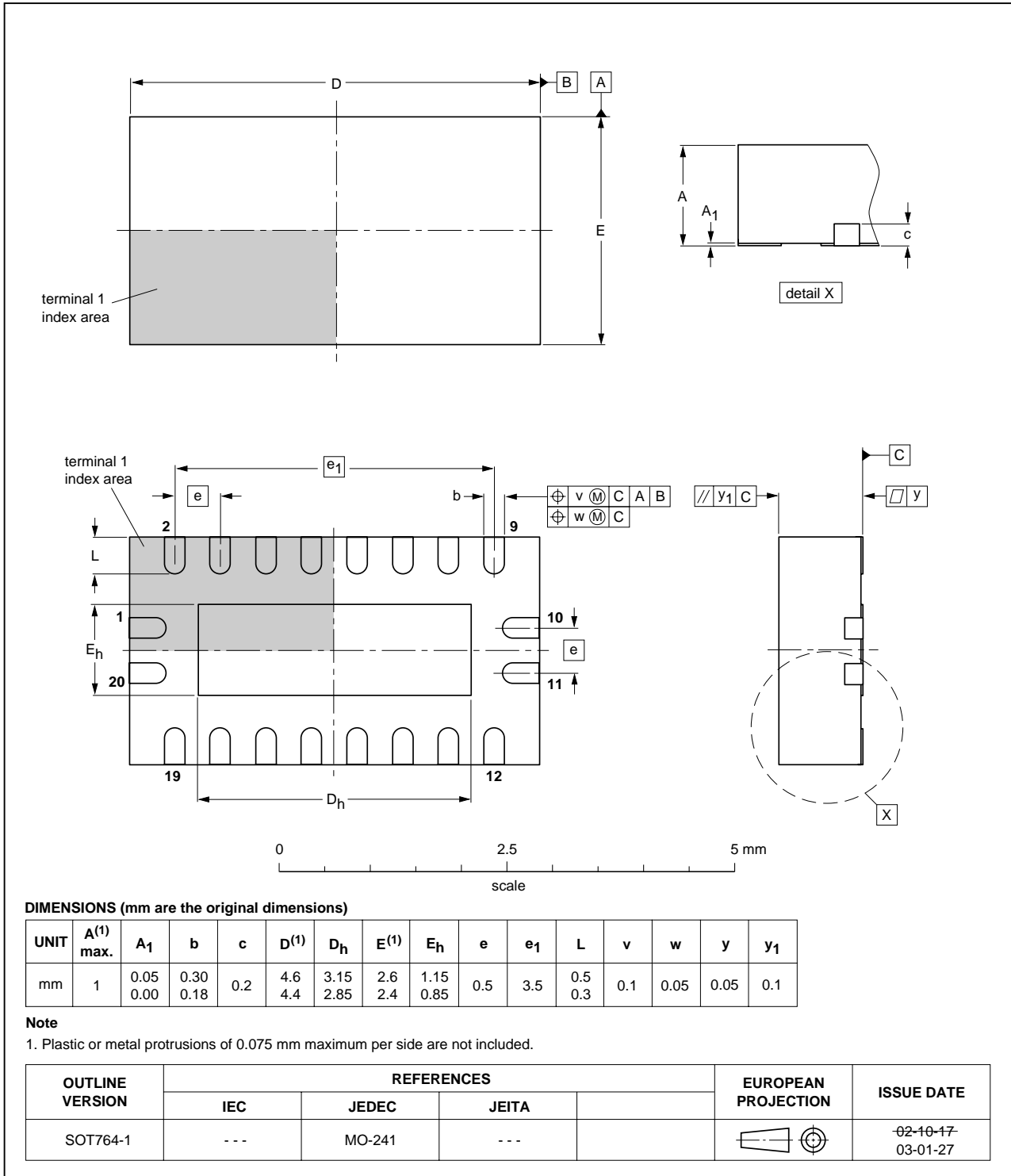


Fig 11. Package outline SOT764-1 (DHVQFN20)

## 13. Abbreviations

Table 10. Abbreviations

| Acronym | Description                                     |
|---------|---|
| BiCMOS  | Bipolar Complementary Metal Oxide Semiconductor |
| DUT     | Device Under Test                               |
| ESD     | ElectroStatic Discharge                         |
| HBM     | Human Body Model                                |
| MM      | Machine Model                                   |
| TTL     | Transistor-Transistor Logic                     |

## 14. Revision history

Table 11. Revision history

| Document ID      | Release date   | Data sheet status     | Change notice | Supersedes       |
|------------------|--|-----------------------|---------------|------------------|
| 74LVT_LVTH244A_4 | 20080903   | Product data sheet    | -             | 74LVT_LVTH244A_3 |
| Modifications:   | <ul style="list-style-type: none"> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> <li><a href="#">Section 3 "Ordering information"</a> and <a href="#">Section 12 "Package outline"</a> DHVQFN20 package added.</li> </ul> |                       |               |                  |
| 74LVT_LVTH244A_3 | 20060315   | Product specification | -             | 74LVT244A_2      |
| 74LVT244A_2      | 19980219   | Product specification | -             | 74LVT244A_1      |

## 15. Legal information

### 15.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition  |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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